## Notice of References Cited Application/Control No. 10/616,037 Examiner William L. Boddie Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0217932	11-2004	Nally et al.	345/092
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